

Notice of References Cited	Application/Control No. 09/171,909	Applicant(s)/Patent Under Reexamination ROY-CHOWDHURY ET AL.	
	Examiner Ron Schwadron, Ph.D.	Art Unit 1644	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,950,469	08-1990	Katz, David H.	424/1.49
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	WO 96/39176	12-1996	WO	Chen et al.	---
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	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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